

Single N-Channel MOSFET

■ DESCRIPTION

SMC2208E is the N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced trench technology devices are well suited for high efficiency fast switching applications, low in-line power loss needed in small outline surface mount package.

■ PART NUMBER INFORMATION

SMC 2208 E SC - TR G

a	b	c	d	e	f
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a : Company name.

b : Product Serial number.

c : ESD

d : Package code SC: SOT-523

e : Handling code TR: Tape&Reel

f : Green produce code G: *RoHS Compliant*

■ FEATURES

$V_{DS} = 20V, I_D = 0.8A$

$R_{DS(ON)} = 210m\Omega(\text{Typ.}) @ V_{GS} = 4.5V$

$R_{DS(ON)} = 245m\Omega(\text{Typ.}) @ V_{GS} = 2.5V$

$R_{DS(ON)} = 310m\Omega(\text{Typ.}) @ V_{GS} = 1.8V$

$R_{DS(ON)} = 380m\Omega(\text{Typ.}) @ V_{GS} = 1.5V$

$R_{DS(ON)} = 615m\Omega(\text{Typ.}) @ V_{GS} = 1.2V$

◆Fast switch

◆Low gate drive applications

◆Low Input Capacitance

■ APPLICATIONS

◆Hand-Held Instruments

◆Load Switch

◆Battery Protection



■ ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ Unless otherwise noted)

Symbol	Parameter	Rating	Units	
V_{DSS}	Drain-Source Voltage	20	V	
V_{GSS}	Gate-Source Voltage	± 8	V	
I_D	Continuous Drain Current	$T_A=25^\circ\text{C}$	0.8	A
		$T_A=70^\circ\text{C}$	0.7	A
I_{DM}	Pulsed Drain Current ^A	3.2	A	
P_D	Power Dissipation ^B	$T_A=25^\circ\text{C}$	0.3	W
		$T_A=70^\circ\text{C}$	0.2	W
T_J	Operation Junction Temperature	-55/150	$^\circ\text{C}$	
T_{STG}	Storage Temperature Range	-55/150	$^\circ\text{C}$	

■ THERMAL RESISTANCE

Symbol	Parameter	Typ	Max	Units
$R_{\theta JA}$	Thermal Resistance Junction to Ambient ^C	$t \leq 10\text{s}$	-	$^\circ\text{C/W}$
	Thermal Resistance Junction to Ambient ^C	Steady-State	416	
$R_{\theta JC}$	Thermal Resistance Junction to Case ^C		-	

ELECTRICAL CHARACTERISTICS($T_A = 25^\circ\text{C}$ Unless otherwise noted)

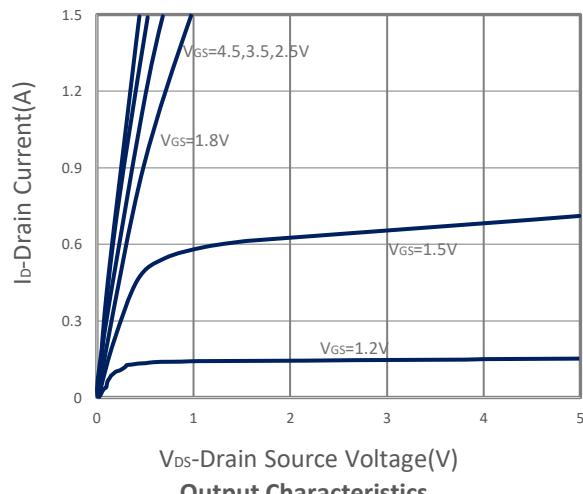
Symbol	Parameter	Condition	Min	Typ	Max	Unit	
Static Parameters							
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0\text{V}, I_D = 250\mu\text{A}$	20			V	
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$	0.3	0.5	1	V	
I_{GSS}	Gate Leakage Current	$V_{DS} = 0\text{V}, V_{GS} = \pm 8\text{V}$			± 20	μA	
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 20\text{V}, V_{GS} = 0\text{V}$ $T_J = 25^\circ\text{C}$			1	μA	
		$V_{DS} = 16\text{V}, V_{GS} = 0\text{V}$ $T_J = 75^\circ\text{C}$			10		
$R_{DS(\text{ON})}$	Drain-source On-Resistance ^D	$V_{GS} = 4.5\text{V}, I_D = 0.6\text{A}$		210	300	$\text{m}\Omega$	
		$V_{GS} = 2.5\text{V}, I_D = 0.5\text{A}$		245	380		
		$V_{GS} = 1.8\text{V}, I_D = 0.3\text{A}$		310	500		
		$V_{GS} = 1.5\text{V}, I_D = 0.2\text{A}$		380	600		
		$V_{GS} = 1.2\text{V}, I_D = 0.1\text{A}$		615	1000		
Source-Drain Diode							
V_{SD}	Diode Forward Voltage ^B	$I_S = 1\text{A}, V_{GS} = 0\text{V}$			1.0	V	
I_S	Continuous Source Current				0.8	A	
Dynamic and Switching Parameters							
Q_g	Total Gate Charge	$V_{DS} = 10\text{V}, V_{GS} = 4.5\text{V}$ $I_D = 0.8\text{A}$		1	1.3	nC	
Q_{gs}	Gate-Source Charge			0.14	0.17		
Q_{gd}	Gate-Drain Charge			0.2	0.27		
C_{iss}	Input Capacitance	$V_{DS} = 10\text{V}, V_{GS} = 0\text{V}$ $f = 1\text{MHz}$		39	46	pF	
C_{oss}	Output Capacitance			14	18		
C_{rss}	Reverse Transfer Capacitance			6	7.8		
$t_{d(on)}$	Turn-On Time ^E	$V_{DD} = 10\text{V}, V_{GEN} = 4.5\text{V},$ $R_G = 10\Omega, I_D = 0.5\text{A}$		5		nS	
t_r				3.5			
$t_{d(off)}$	Turn-Off Time ^E			14			
t_f				6			

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

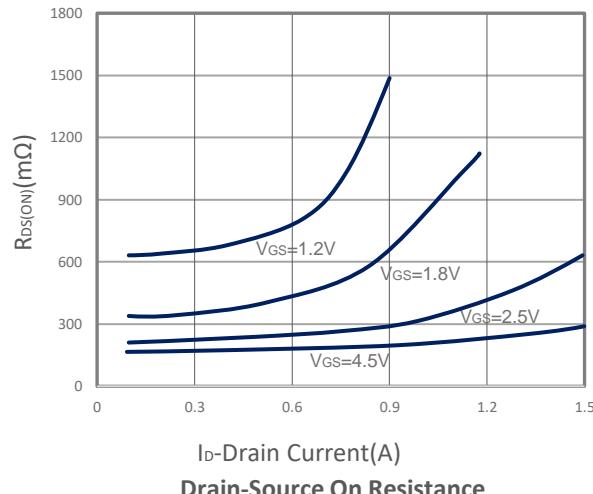
- A. The value of $R_{\theta JA}$ is measured with the device in a still air environment with maximum junction temperature $T_J(\text{MAX}) = 150^\circ\text{C}$ (initial temperature $T_A = 25^\circ\text{C}$)..
- B. The $T_J(\text{MAX}) = 150^\circ\text{C}$, using junction-to-ambient thermal resistance.
- C. Surface-mounted on FR-4 board using 1 sq-in pad, 2 oz Cu, in a still air environment with $T_A = 25^\circ\text{C}$.
- D. The data tested by pulsed, pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$
- E. Pulsed width limited by maximum junction temperature.

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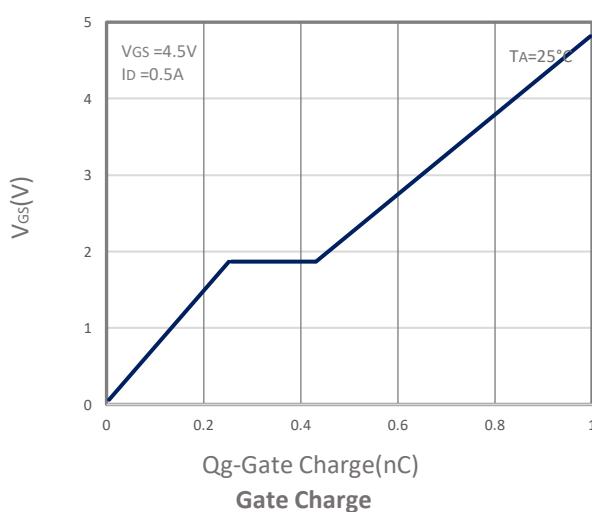
■ TYPICAL CHARACTERISTICS



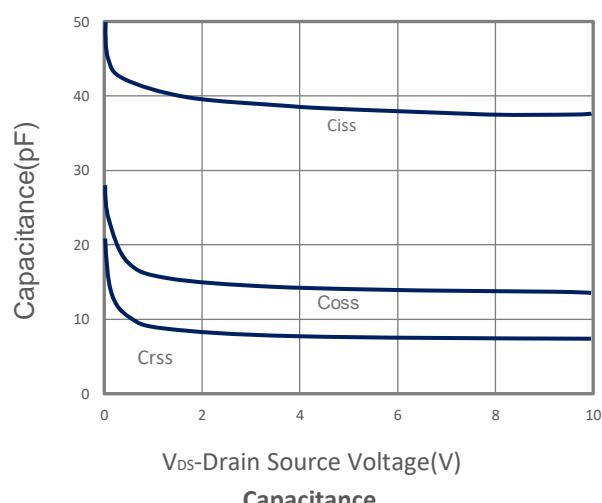
Output Characteristics



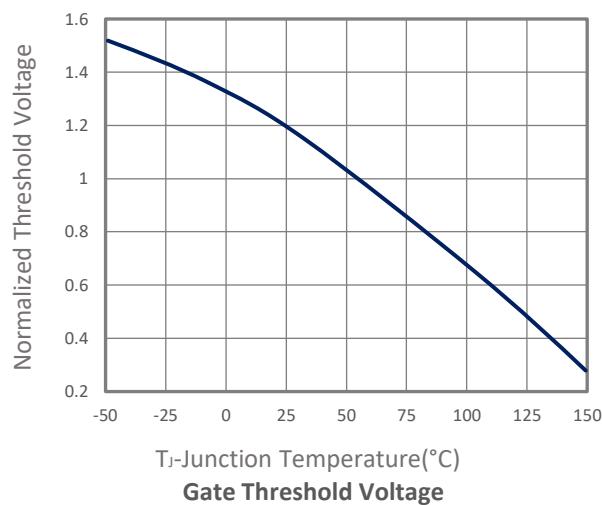
Drain-Source On Resistance



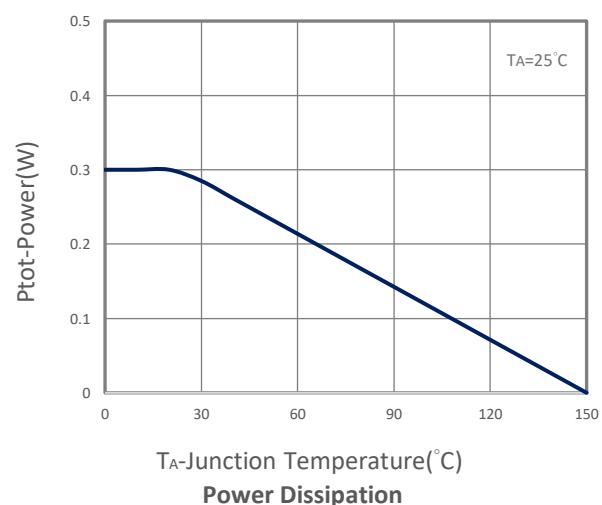
Gate Charge



Capacitance

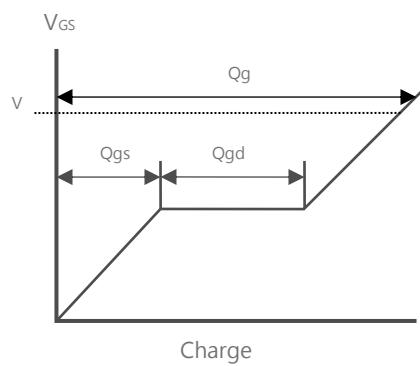
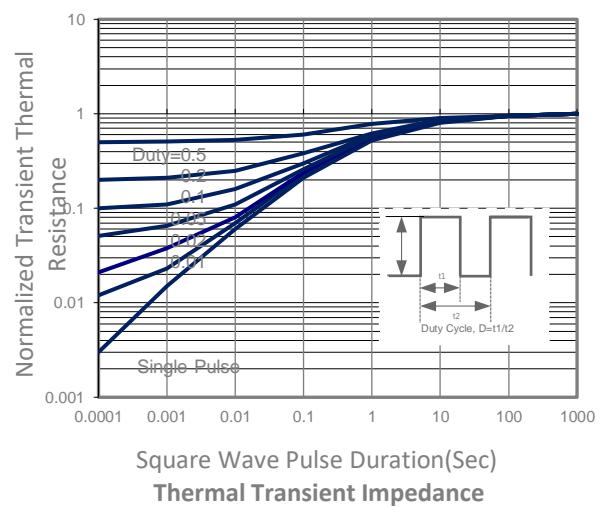
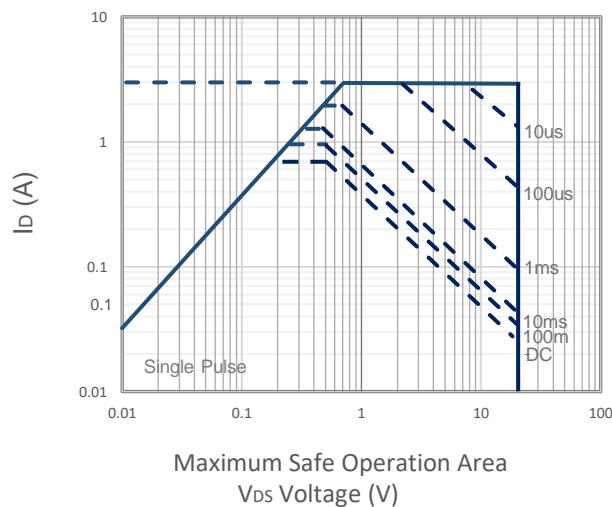
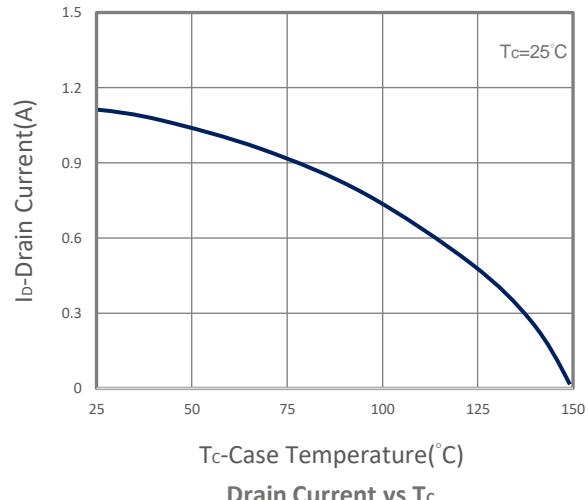
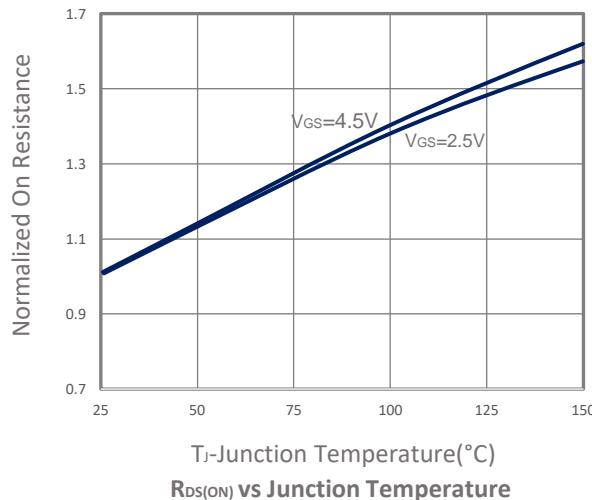


Gate Threshold Voltage

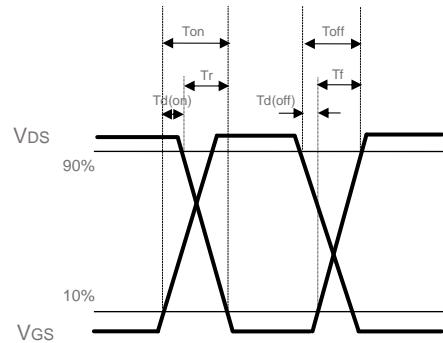


Power Dissipation

■ TYPICAL CHARACTERISTICS

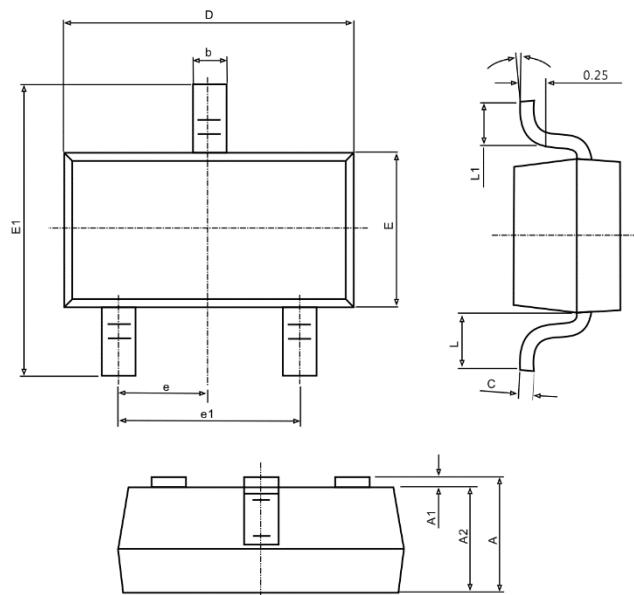


Gate Charge Waveform

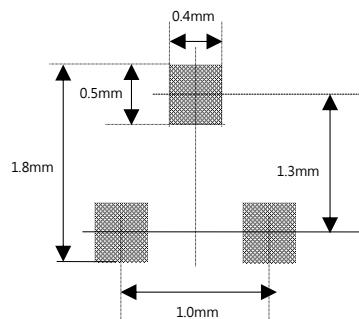


Switching Time Waveform

■ SOT-523 PACKAGE DIMENSIONS



Recommended Land Pattern



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.700	0.900	0.028	0.035
A1	0.000	0.100	0.000	0.004
A2	0.700	0.800	0.028	0.031
b	0.250	0.350	0.010	0.014
c	0.100	0.200	0.004	0.008
D	1.500	1.750	0.059	0.069
E	0.700	0.900	0.028	0.035
E1	1.400	1.750	0.055	0.069
e	0.500 TYP.		0.020 TYP..	
e1	0.900	1.100	0.035	0.043
L	0.300	0.460	0.012	0.018
L1	0.260	0.460	0.010	0.018
Θ	0°	8°	0°	8°